

# Minority Carrier Lifetime and Recombination Dynamics in Strain-Balanced GaInAs/InAsSb superlattices

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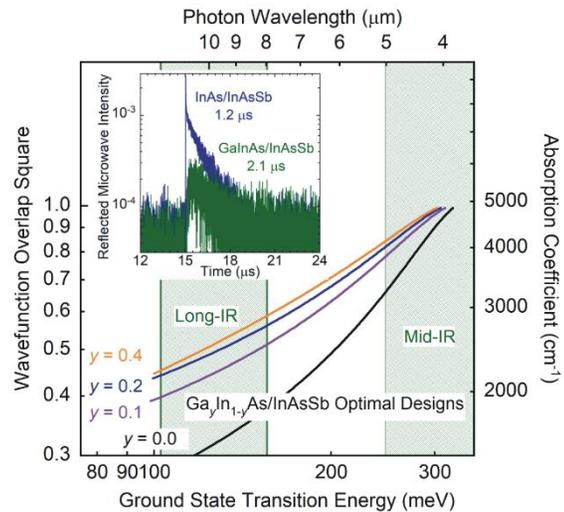
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Strain-balanced InAs/InAsSb superlattices are rapidly emerging as a contending mid-infrared sensing technology as decreasing dark currents lead to ever more sensitive detectors. Dark current can be minimized by increasing the absorption coefficient and utilizing a thinner absorber region, thereby reducing the volume over which dark current is generated. While the InAs/InAsSb superlattice design may be optimized for maximum absorption [1], there remains great room for improvement by establishing a more favorable strain-balance condition. Specifically, replacing the lightly-tensile InAs layers with more-tensile GaInAs leads to a more symmetric wavefunction overlap profile and correspondingly stronger absorption for the same energy cutoff [2]. The figure plots the wavefunction overlap square and absorption coefficient of GaInAs/InAsSb superlattices designed for maximum absorption as a function of ground state transition energy, which shows that absorption coefficient improves substantially with Ga content up to 20%.

In this work, two strain-balanced GaInAs/InAsSb superlattices (0% and 20% Ga) designed for maximum absorption at 5  $\mu\text{m}$  wavelength are examined using temperature- and excitation-dependent photoluminescence spectroscopy and time-resolved microwave reflectance. The superlattices are 1  $\mu\text{m}$  thick and doped  $4 \times 10^{15} \text{ cm}^{-3}$   $n$ -type in order to examine the optimal doping density  $\times$  lifetime product in a potential diffusion-limited detector [3]. The 77 K time-resolved microwave reflectance decay for each sample is plotted in the figure inset, with the minority carrier lifetimes of 1.2  $\mu\text{s}$  and 2.1  $\mu\text{s}$  labeled in the plot. The photoluminescence is evaluated using a recombination rate model to extract the Shockley-Read-Hall, radiative, and Auger rate constants as a function of temperature, to compare to the temperature-dependent minority carrier lifetimes determined by the time-resolved photoconductivity decay.



Wavefunction overlap square and absorption coefficient of GaInAs/InAsSb superlattice designs. Inset shows photoconductivity decay of 5  $\mu\text{m}$  wavelength designs with 0% and 20% Ga in GaInAs.

[1] P. T. Webster, et. al., J. Appl. Phys. **119**, 225701 (2016).

[2] G. Ariyawansa, et. al., Appl. Phys. Lett. **108**, 022106 (2016).

[3] E. A. Kadlec, et. al., Appl. Phys. Lett. **109**, 261105 (2016).

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